

SOT-23

RoHS
COMPLIANT

Pb
Pb-Free

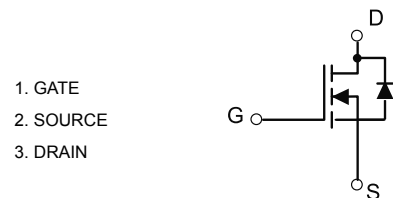
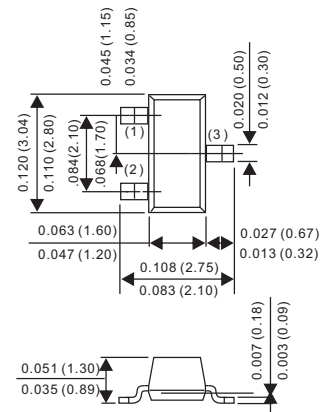
FEATURE

- Surface Mount Package
- High Density Cell Design for Extremely Low $R_{DS(ON)}$
- Voltage Controlled Small Signal Switch
- Rugged and Reliable

APPLICATION

- Small Servo Motor Controls
- Power MOSFET Gate Drivers
- Switching Application

MARKING B123 OR SA



Dimensions in inches and (millimeters)

MAXIMUM RATINGS ($T_a=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
N-MOSFET			
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current (note 1)	I_D	0.2	A
Pulsed Drain Current ($t_p=10\mu\text{s}$)	I_{DM}	0.8	A
Continuous Source-Drain Diode Current	I_S	0.17	A
Power Dissipation	P_D	0.3	W
Thermal Resistance from Junction to Ambient (note 1)	$R_{\theta JA}$	400	$^{\circ}\text{C/W}$
Junction Temperature	T_J	150	$^{\circ}\text{C}$
Storage Temperature	T_{STG}	$-55 \sim +150$	$^{\circ}\text{C}$
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	T_L	260	$^{\circ}\text{C}$



MOSFET ELECTRICAL CHARACTERISTICS $T_a=25\text{ }^{\circ}\text{C}$ unless otherwise specified

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
STATIC CHARACTERISTICS						
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D =250μA	100			V
Zero gate voltage drain current	I _{DSS}	V _{DS} =100V,V _{GS} = 0V Ta=25 ℃			1	μA
		V _{DS} =80V,V _{GS} = 0V Ta=125 ℃			100	uA
Gate-body leakage current	I _{GSS}	V _{GS} =±20V, V _{DS} = 0V			±10	uA
Gate threshold voltage (note 2)	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	1	2.0	3.0	V
Drain-source on-resistance(note 2)	R _{DS(on)}	V _{GS} =10V, I _D =0.2A		3.5	6	Ω
		V _{GS} =4.5V, I _D =0.1A		4	8	Ω
Forward tranconductance(note 2)	g _{FS}	V _{DS} =10V, I _D =170mA	80			mS
Diode forward voltage	V _{SD}	I _{SD} =200mA, V _{GS} = 0V		0.85	1.2	V
DYNAMIC CHARACTERISTICS (note 4)						
Input Capacitance	C _{iss}	V _{DS} =50V,V _{GS} =0V,f =1MHz		31.6		pF
Output Capacitance	C _{oss}			2.8		pF
Reverse Transfer Capacitance	C _{rss}			2		pF
SWITCHING CHARACTERISTICS (note 3,4)						
Turn-on delay time	t _{d(on)}	V _{GS} =10V,V _{DD} =50V, I _D =0.2A,R _{GEN} =3.3 Ω		2		ns
Turn-on rise time	t _r			3.1		ns
Turn-off delay time	t _{d(off)}			6.5		ns
Turn-off fall time	t _f			15		ns
Total Gate Charge	Q _g	V _{DS} =50V,I _D =0.2A, V _{GS} =10V		0.74		nC
Gate-Source Charge	Q _{gs}			0.08		nC
Gate-Drain Charge	Q _{gd}			0.26		nC

Notes :

- 1.Surface mounted on FR4 board using the minimum recommended pad size.
2. Pulse Test : Pulse width=300 μs , duty cycle $\leq 2\%$.
3. switching characteristics are independent of operating junction temperature.
4. Guaranteed by design, not subject to production.

Typical Characteristics

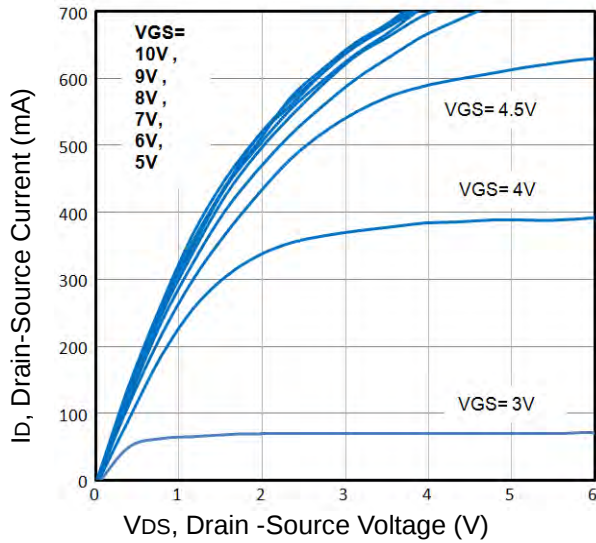


Fig1. Typical Output Characteristics

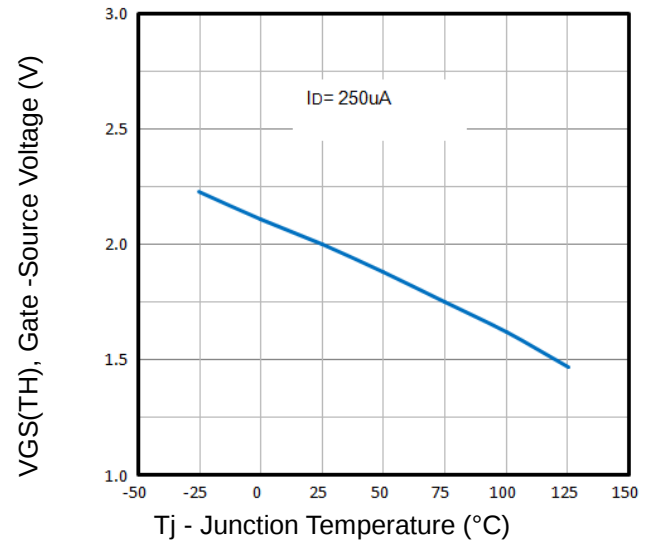


Fig2. Normalized Threshold Voltage Vs. Temperature

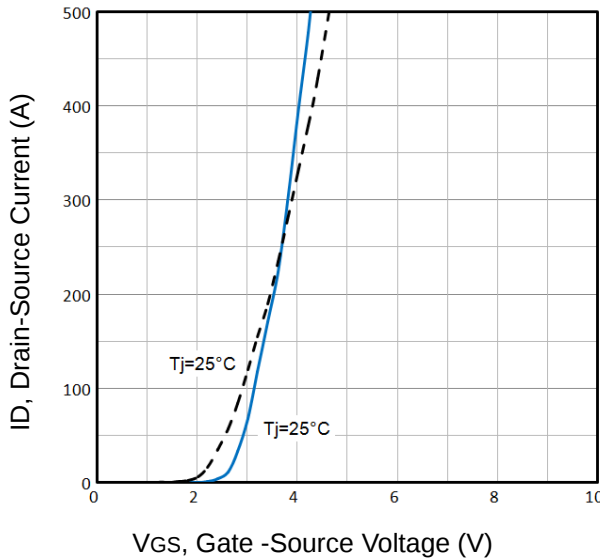


Fig3. Typical Transfer Characteristics

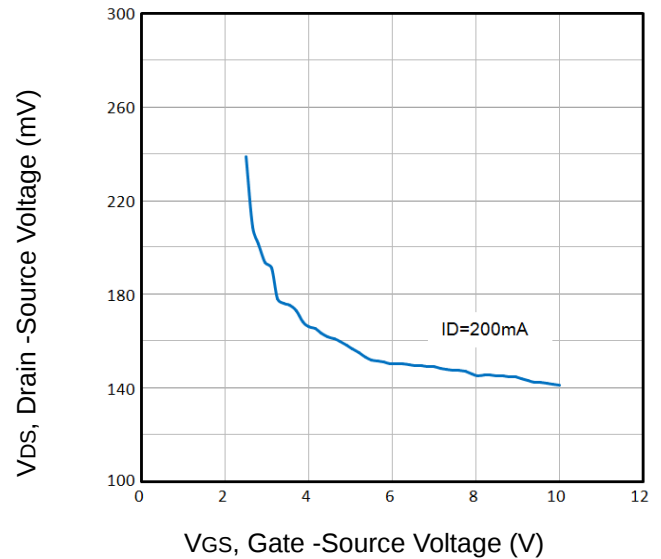


Fig4. Drain-Source Voltage vs Gate-Source Voltage

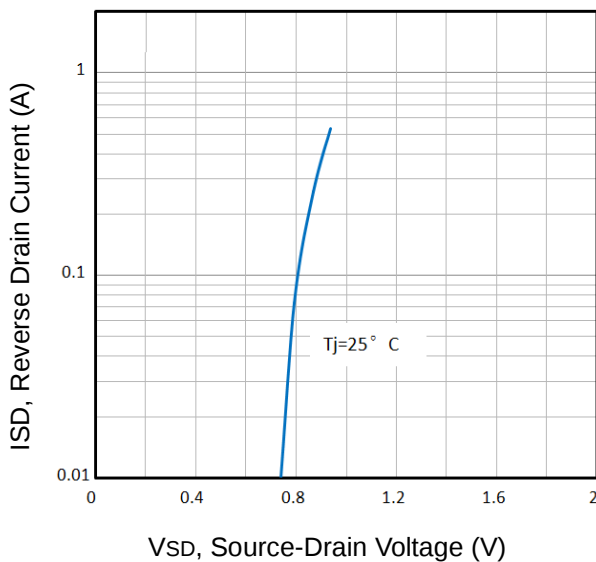


Fig5. Typical Source-Drain Diode Forward Voltage

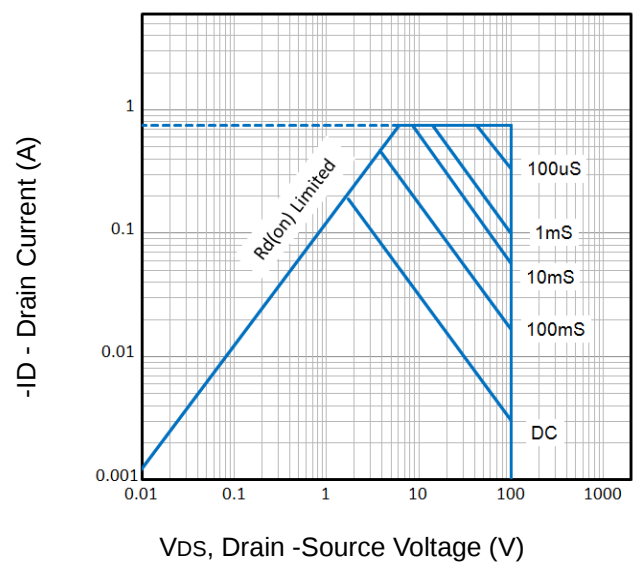


Fig6. Maximum Safe Operating Area

Typical Characteristics

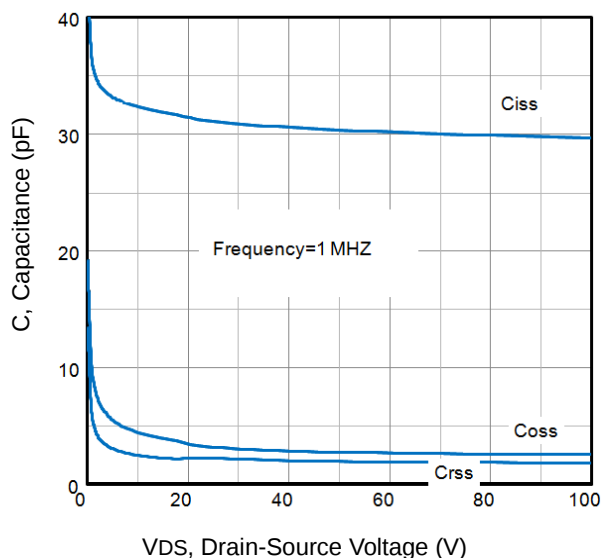


Fig7. Typical Capacitance Vs. Drain-Source Voltage

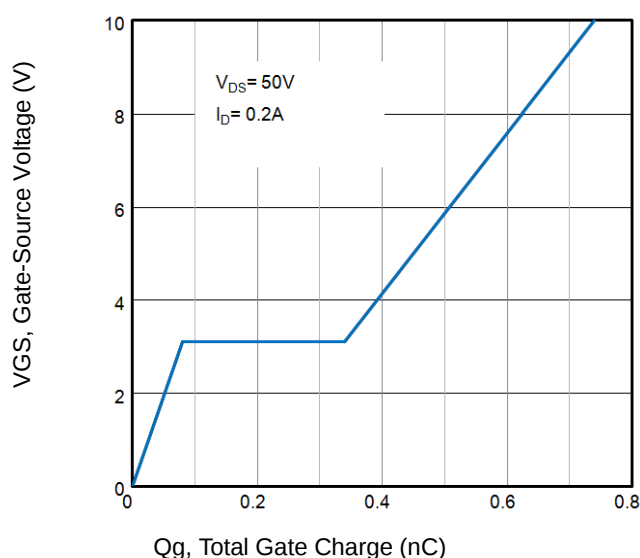


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

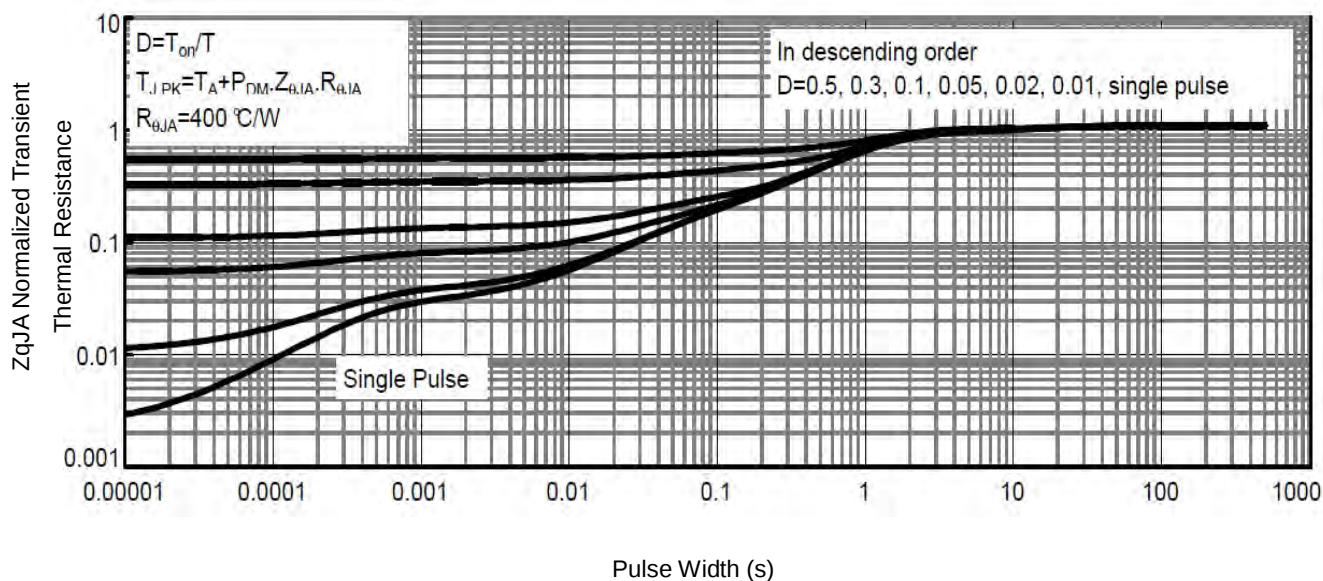


Fig9. Normalized Maximum Transient Thermal Impedance

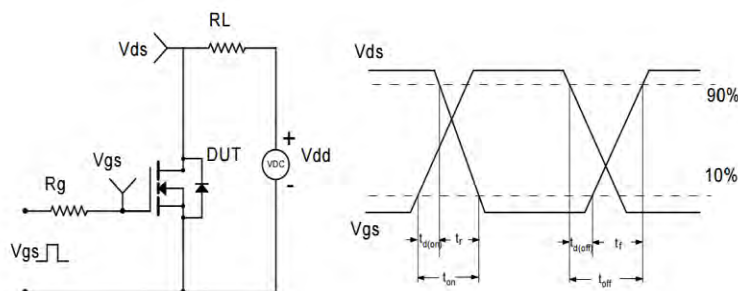


Fig10. Switching Time Test Circuit and waveforms